

# S70FL01GS

1 Gbit (128 Mbyte) MirrorBit® Flash Non-Volatile Memory  
CMOS 3.0 Volt Core  
Serial Peripheral Interface with Multi-I/O

*Data Sheet*

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# S70FL01GS

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**CMOS 3.0 Volt Core**  
**Serial Peripheral Interface with Multi-I/O**



## Data Sheet

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## Features

### ■ Serial Peripheral Interface (SPI)

- SPI Clock polarity and phase modes 0 and 3
- Double Data Rate (DDR) option
- Extended Addressing: 32-bit address
- Serial Command set and footprint compatible with S25FL-A, S25FL-K, and S25FL-P SPI families
- Multi I/O Command set and footprint compatible with S25FL-P SPI family

### ■ READ Commands

- Normal, Fast, Dual, Quad, Fast DDR, Dual DDR, Quad DDR
- AutoBoot – power up or reset and execute a Normal or Quad read command automatically at a preselected address
- Common Flash Interface (CFI) data for configuration information

### ■ Programming (1.5 Mbytes/s)

- 512-byte Page Programming buffer
- Quad-Input Page Programming (QPP) for slow clock systems

### ■ Erase (0.5 Mbytes/s)

- Uniform 256-kbyte sectors

### ■ Cycling Endurance

- 100,000 Program-Erase Cycles on any sector typical

### ■ Data Retention

- 20 Year Data Retention typical

## Security Features

### ■ One Time Program (OTP) array of 1024 bytes

### ■ Block Protection

- Status Register bits to control protection against program or erase of a contiguous range of sectors.
- Hardware and software control options
- Advanced Sector Protection (ASP)
- Individual sector protection controlled by boot code or password

### ■ Spansion 65 nm MirrorBit Technology with Eclipse™ Architecture

### ■ Core Supply Voltage: 2.7V to 3.6V

### ■ I/O Supply Voltage: 1.65V to 3.6V

### ■ Temperature Range:

- Industrial (-40°C to +85°C)
- Automotive In-Cabin (-40°C to +105°C)

### ■ Packages (all Pb-free)

- 16-lead SOIC (300 mils)
- BGA-24, 8 x 6 mm
  - 5 x 5 ball (FAB024) footprint

## General Description

This document contains information for the S70FL01GS device, which is a dual die stack of two S25FL512S die. For detailed specifications, please refer to the discrete die data sheet:

| Document             | Publication Identification Number (PID) |
|----------------------|-----------------------------------------|
| S25FL512S Data Sheet | S25FL512S_00                            |

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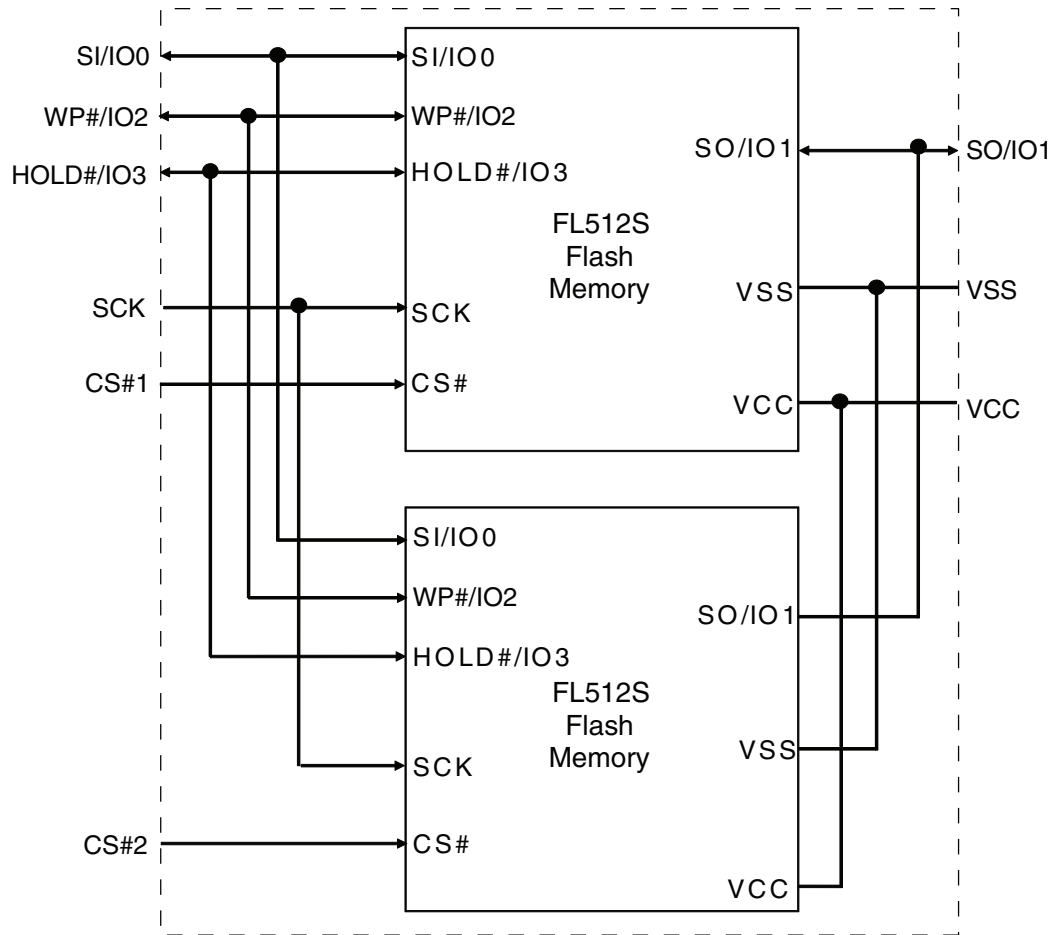
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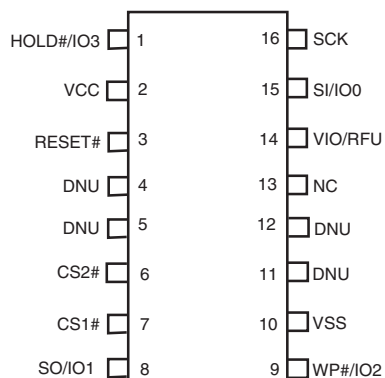
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## 1. Block Diagram

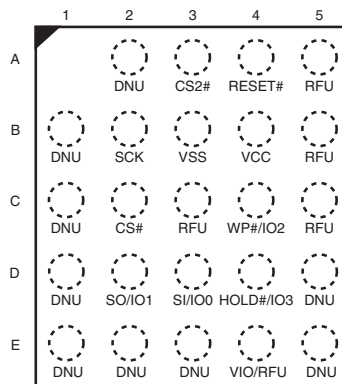


## 2. Connection Diagrams

**Figure 2.1** 16-Pin Plastic Small Outline Package (SO)



**Figure 2.2** 24-Ball BGA, 5 x 5 Ball Footprint (FAB024), Top View



**Note:**

1.  $V_{IO}$  is not supported in the S70FL01GS device and is RFU. Refer to [Section 8](#) for more details.



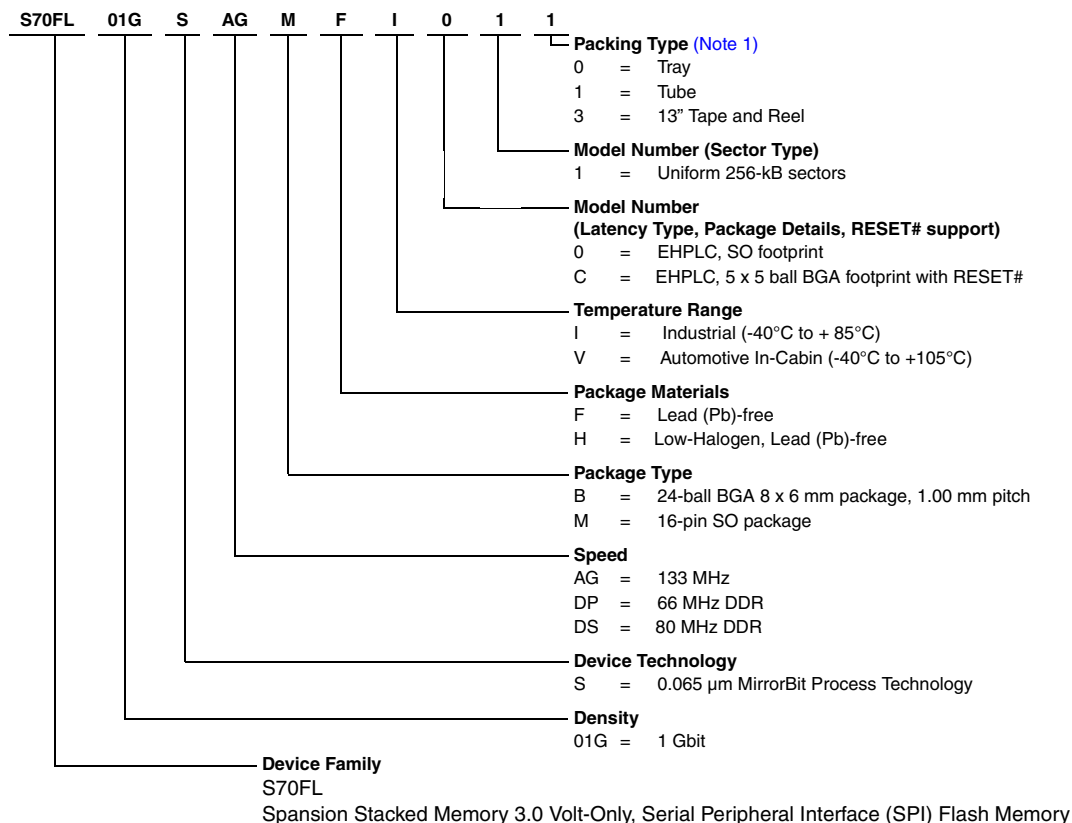
### 3. Input/Output Summary

Table 3.1 Signal List

| Signal Name     | Type     | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
|-----------------|----------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| RESET#          | Input    | <b>Hardware Reset:</b> Low = device resets and returns to standby state, ready to receive a command. The signal has an internal pull-up resistor and may be left unconnected in the host system if not used.                                                                                                                                                                                                                                                                                                                                                             |
| SCK             | Input    | <b>Serial Clock.</b>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| CS#             | Input    | <b>Chip Select.</b>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                      |
| SI / IO0        | I/O      | <b>Serial Input</b> for single bit data commands or IO0 for Dual or Quad commands.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                       |
| SO / IO1        | I/O      | <b>Serial Output</b> for single bit data commands. IO1 for Dual or Quad commands.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                        |
| WP# / IO2       | I/O      | <b>Write Protect</b> when not in Quad mode. IO2 in Quad mode. The signal has an internal pull-up resistor and may be left unconnected in the host system if not used for Quad commands.                                                                                                                                                                                                                                                                                                                                                                                  |
| HOLD# / IO3     | I/O      | <b>Hold</b> (pause) serial transfer in single bit or Dual data commands. IO3 in Quad-I/O mode. The signal has an internal pull-up resistor and may be left unconnected in the host system if not used for Quad commands.                                                                                                                                                                                                                                                                                                                                                 |
| V <sub>CC</sub> | Supply   | <b>Core Power Supply.</b>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                |
| V <sub>IO</sub> | Supply   | <b>Versatile I/O Power Supply. Note:</b> V <sub>IO</sub> is not supported in the S70FL01GS device. Refer to <a href="#">Section 8</a> . for more details.                                                                                                                                                                                                                                                                                                                                                                                                                |
| V <sub>SS</sub> | Supply   | <b>Ground.</b>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                           |
| NC              | Unused   | <b>Not Connected.</b> No device internal signal is connected to the package connector nor is there any future plan to use the connector for a signal. The connection may safely be used for routing space for a signal on a Printed Circuit Board (PCB). However, any signal connected to an NC must not have voltage levels higher than V <sub>CC</sub> .                                                                                                                                                                                                               |
| RFU             | Reserved | <b>Reserved for Future Use.</b> No device internal signal is currently connected to the package connector but there is potential future use of the connector for a signal. It is recommended to not use RFU connectors for PCB routing channels so that the PCB may take advantage of future enhanced features in compatible footprint devices.                                                                                                                                                                                                                          |
| DNU             | Reserved | <b>Do Not Use.</b> A device internal signal may be connected to the package connector. The connection may be used by Spansion for test or other purposes and is not intended for connection to any host system signal. Any DNU signal related function will be inactive when the signal is at V <sub>IL</sub> . The signal has an internal pull-down resistor and may be left unconnected in the host system or may be tied to V <sub>SS</sub> . Do not use these connections for PCB signal routing channels. Do not connect any host system signal to this connection. |

## 4. Ordering Information

The ordering part number is formed by a valid combination of the following:



### Notes:

1. EHPLC = Enhanced High Performance Latency Code table.
2. Uniform 256-kB sectors = All sectors are uniform 256-kB with a 512B programming buffer.

## 4.1 Valid Combinations

Table 4.1 lists the valid combinations configurations planned to be supported in volume for this device.

**Table 4.1** S70FL01GS Valid Combinations Table

| S70FL01GS Valid Combinations |              |                         |              |              | Package Marking (1)                      |
|------------------------------|--------------|-------------------------|--------------|--------------|------------------------------------------|
| Base Ordering Part Number    | Speed Option | Package and Temperature | Model Number | Packing Type |                                          |
| S70FL01GS                    | AG           | MFI, MFV                | 01           | 0, 1, 3      | FL01GS + A + (temp) + F + (Model Number) |
|                              | DP           |                         |              |              | FL01GS + D + (temp) + F + (Model Number) |
|                              | AG           | BHI                     | C1           | 0, 3         | FL01GS + A + (temp) + H + (Model Number) |

### Note:

1. Package Marking omits the leading "S70" and package type.

## 5. Device Operations

### 5.1 Programming

Each Flash die must be programmed independently due to the nature of the dual die stack.

### 5.2 Simultaneous Die Operation

The user may only access one Flash die of the dual die stack at a time via its respective Chip Select.

### 5.3 Sequential Reads

Sequential reads are not supported across the end of the first Flash die to the beginning of the second. If the user desires to sequentially read across the two die, data must be read out of the first die via CS1# and then read out of the second die via CS2#.

### 5.4 Sector/Bulk Erase

A sector erase command must be issued for sectors in each Flash die separately. Full device Bulk Erase via a single command is not supported due to the nature of the dual die stack. A Bulk Erase command must be issued for each die.

### 5.5 Status Registers

Each Flash die of the dual die stack is managed by its own Status Registers. Reads and updates to the Status Registers must be managed separately. It is recommended that Status Register control bit settings of each die are kept identical to maintain consistency when switching between die.

### 5.6 Configuration Register

Each Flash die of the dual die stack is managed by its own Configuration Register. Updates to the Configuration Register control bits must be managed separately. It is recommended that Configuration Register control bit settings of each die are kept identical to maintain consistency when switching between die.

### 5.7 Bank Address Register

It is recommended that the Bank Address Register bit settings of each die are kept identical to maintain consistency when switching between die.

### 5.8 ASP Register, Password Register, PPB Lock Register, PPB Access Register, DYB Access Register, DDR Data Learning Registers

It is recommended that the bit settings for all of the above registers in each die are kept identical to maintain consistency when switching between die.

### 5.9 Block Protection

Each Flash die of the dual die stack will maintain its own Block Protection. Updates to the TBPROT and BPNV bits of each die must be managed separately. By default, each die is configured to be protected starting at the top (highest address) of each array, but no address range is protected. It is recommended that the Block Protection settings of each die are kept identical to maintain consistency when switching between die. In addition, any update to the FREEZE bit must be managed separately for each die. If the FREEZE bit is set to a logic 1, it cannot be cleared to a logic 0 until a power-on-reset is executed on each die that has the FREEZE bit set to 1.

## 6. Read Identification (RDID)

The Read Identification (RDID) command outputs the one-byte manufacturer identification, followed by the two-byte device identification and the bytes for the Common Flash Interface (CFI) tables. Each die of the FL01GS dual die stack will have identical identification data as the FL512S die, with the exception of the CFI data at byte 27h, as shown in [Table 6.1](#).

**Table 6.1** Product Group CFI Device Geometry Definition

| Byte | Data | Description              |
|------|------|--------------------------|
| 27h  | 1Bh  | Device Size = $2^N$ byte |

## 7. RESET#

Note that the hardware RESET# input (pin 3 on the 16-pin SO package and ball A4 on the 5x5 BGA package) is bonded out and active for the S70FL01GS device. For applications that do NOT require use of the RESET# pin, it is recommended to not use RESET# for PCB routing channels that would cause the RESET# signal to be asserted Low ( $V_{IL}$ ). Doing so will cause the device to reset to standby state. The RESET# signal has an internal pull-up resistor and may be left unconnected in the host system if not used.

## 8. Versatile I/O Power Supply ( $V_{IO}$ )

Note that the Versatile I/O ( $V_{IO}$ ) power supply (pin 14 on the 16-pin SO package and ball E4 on the 5x5 BGA package) is not supported, and pin 14 and ball E4 are RFU (Reserved for Future Use) in the standard configuration of the S70FL01GS device. Contact your local sales office to confirm availability with the  $V_{IO}$  feature enabled.

## 9. DC Characteristics

This section summarizes the DC Characteristics of the device.

**Table 9.1** DC Characteristics

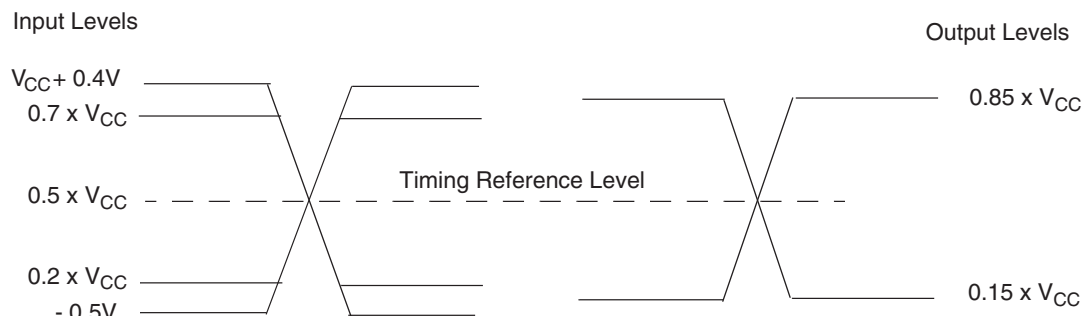
| Symbol                | Parameter                                  | Test Conditions                                                                                                                                                | Min                  | Typ (1) | Max                        | Unit          |
|-----------------------|--------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------|---------|----------------------------|---------------|
| $V_{IL}$              | Input Low Voltage                          |                                                                                                                                                                | -0.5                 |         | $0.2 \times V_{CC}$        | V             |
| $V_{IH}$              | Input High Voltage                         |                                                                                                                                                                | $0.7 \times V_{CC}$  |         | $V_{CC} + 0.4$             | V             |
| $V_{OL}$              | Output Low Voltage                         | $I_{OL} = 1.6 \text{ mA}$ , $V_{CC} = V_{CC \text{ min}}$                                                                                                      |                      |         | $0.15 \times V_{CC}$       | V             |
| $V_{OH}$              | Output High Voltage                        | $I_{OH} = -0.1 \text{ mA}$                                                                                                                                     | $0.85 \times V_{CC}$ |         |                            | V             |
| $I_{LI}$              | Input Leakage Current                      | $V_{CC} = V_{CC \text{ Max}}$ , $V_{IN} = V_{IH}$ or $V_{IL}$                                                                                                  |                      |         | $\pm 4$                    | $\mu\text{A}$ |
| $I_{LO}$              | Output Leakage Current                     | $V_{CC} = V_{CC \text{ Max}}$ , $V_{IN} = V_{IH}$ or $V_{IL}$                                                                                                  |                      |         | $\pm 4$                    | $\mu\text{A}$ |
| $I_{CC1}$             | Active Power Supply Current (READ)         | Serial SDR @ 50 MHz<br>Serial SDR @ 133 MHz<br>Quad SDR @ 80 MHz<br>Quad SDR @ 104 MHz<br>Quad DDR @ 66 MHz<br>Outputs unconnected during read data return (2) |                      |         | 18<br>36<br>50<br>61<br>75 | mA            |
| $I_{CC2}$             | Active Power Supply Current (Page Program) | $CS\# = V_{CC}$                                                                                                                                                |                      |         | 100                        | mA            |
| $I_{CC3}$             | Active Power Supply Current (WRR)          | $CS\# = V_{CC}$                                                                                                                                                |                      |         | 100                        | mA            |
| $I_{CC4}$             | Active Power Supply Current (SE)           | $CS\# = V_{CC}$                                                                                                                                                |                      |         | 100                        | mA            |
| $I_{CC5}$             | Active Power Supply Current (BE) (3)       | $CS\# = V_{CC}$                                                                                                                                                |                      |         | 100                        | mA            |
| $I_{SB}$ (Industrial) | Standby Current                            | RESET#, $CS\# = V_{CC}$ ; SI, SCK = $V_{CC}$ or $V_{SS}$ , Industrial Temp                                                                                     |                      | 70      | 200                        | $\mu\text{A}$ |
| $I_{SB}$ (Automotive) | Standby Current                            | RESET#, $CS\# = V_{CC}$ ; SI, SCK = $V_{CC}$ or $V_{SS}$ , Automotive Temp                                                                                     |                      | 70      | 300                        | $\mu\text{A}$ |

**Notes:**

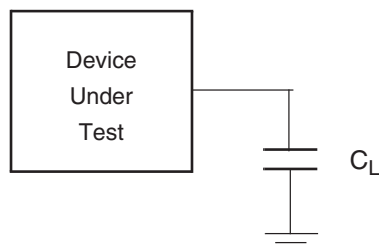
1. Typical values are at  $T_{AI} = 25^\circ\text{C}$  and  $V_{CC} = 3\text{V}$ .
2. Output switching current is not included.
3. Bulk Erase is on a per-die basis, not for the whole device.

## 10. AC Test Conditions

**Figure 10.1** Input, Output, and Timing Reference Levels



**Figure 10.2** Test Setup



**Table 10.1** AC Measurement Conditions

| Symbol | Parameter                 | Min                                        | Max | Unit |
|--------|---------------------------|--------------------------------------------|-----|------|
| $C_L$  | Load Capacitance          | 30<br>15 (4)                               |     | pF   |
|        | Input Rise and Fall Times |                                            | 2.4 | ns   |
|        | Input Pulse Voltage       | $0.2 \times V_{CC}$ to $0.8 \times V_{CC}$ |     | V    |
|        | Input Timing Ref Voltage  | $0.5 \times V_{CC}$                        |     | V    |
|        | Output Timing Ref Voltage | $0.5 \times V_{CC}$                        |     | V    |

**Notes:**

1. Output High-Z is defined as the point where data is no longer driven.
2. Input slew rate: 1.5 V/ns.
3. AC characteristics tables assume clock and data signals have the same slew rate (slope).
4. DDR Operation.

## 11. SDR AC Characteristics

**Table 11.1** SDR AC Characteristics (Single Die Package,  $V_{CC} = 2.7V$  to  $3.6V$ )

| Symbol              | Parameter                                                                                                    | Min            | Typ | Max                            | Unit |
|---------------------|--------------------------------------------------------------------------------------------------------------|----------------|-----|--------------------------------|------|
| $F_{SCK, R}$        | SCK Clock Frequency for READ and 4READ instructions                                                          | DC             |     | 50                             | MHz  |
| $F_{SCK, C}$        | SCK Clock Frequency for single commands (4)                                                                  | DC             |     | 133                            | MHz  |
| $F_{SCK, C}$        | SCK Clock Frequency for the following dual and quad commands: DOR, 4DOR, QOR, 4QOR, DIOR, 4DIOR, QIOR, 4QIOR | DC             |     | 104                            | MHz  |
| $F_{SCK, QPP}$      | SCK Clock Frequency for the QPP, 4QPP commands                                                               | DC             |     | 80                             | MHz  |
| $P_{SCK}$           | SCK Clock Period                                                                                             | $1/F_{SCK}$    |     | $\infty$                       |      |
| $t_{WH}, t_{CH}$    | Clock High Time (5)                                                                                          | $45\% P_{SCK}$ |     |                                | ns   |
| $t_{WL}, t_{CL}$    | Clock Low Time (5)                                                                                           | $45\% P_{SCK}$ |     |                                | ns   |
| $t_{CRT}, t_{CLCH}$ | Clock Rise Time (slew rate)                                                                                  | 0.1            |     |                                | V/ns |
| $t_{CFT}, t_{CHCL}$ | Clock Fall Time (slew rate)                                                                                  | 0.1            |     |                                | V/ns |
| $t_{CS}$ (7)        | CS# High Time (Read Instructions)<br>CS# High Time (Program/Erase)                                           | 10<br>50       |     |                                | ns   |
| $t_{CSS}$           | CS# Active Setup Time (relative to SCK)                                                                      | 3              |     |                                | ns   |
| $t_{CSH}$           | CS# Active Hold Time (relative to SCK)                                                                       | 3              |     | 3000 (6)                       | ns   |
| $t_{SU}$            | Data in Setup Time                                                                                           | 3              |     |                                | ns   |
| $t_{HD}$            | Data in Hold Time                                                                                            | 2              |     |                                | ns   |
| $t_V$               | Clock Low to Output Valid                                                                                    |                |     | 8.0 (2)<br>7.65 (3)<br>6.5 (4) | ns   |
| $t_{HO}$            | Output Hold Time                                                                                             | 2              |     |                                | ns   |
| $t_{DIS}$           | Output Disable Time                                                                                          | 0              |     | 8                              | ns   |
| $t_{WPS}$           | WP# Setup Time                                                                                               | 20 (1)         |     |                                | ns   |
| $t_{WPH}$           | WP# Hold Time                                                                                                | 100 (1)        |     |                                | ns   |
| $t_{HLCH}$          | HOLD# Active Setup Time (relative to SCK)                                                                    | 3              |     |                                | ns   |
| $t_{CHHH}$          | HOLD# Active Hold Time (relative to SCK)                                                                     | 3              |     |                                | ns   |
| $t_{HHCH}$          | HOLD# Non-Active Setup Time (relative to SCK)                                                                | 3              |     |                                | ns   |
| $t_{CHHL}$          | HOLD# Non-Active Hold Time (relative to SCK)                                                                 | 3              |     |                                | ns   |
| $t_{HZ}$            | HOLD# Enable to Output Invalid                                                                               |                |     | 8                              | ns   |
| $t_{LZ}$            | HOLD# Disable to Output Valid                                                                                |                |     | 8                              | ns   |

**Notes:**

1. Only applicable as a constraint for WRR instruction when SRWD is set to a 1.
2. Full  $V_{CC}$  range (2.7 - 3.6V) and  $CL = 30$  pF.
3. Regulated  $V_{CC}$  range (3.0 - 3.6V) and  $CL = 30$  pF.
4. Regulated  $V_{CC}$  range (3.0 - 3.6V) and  $CL = 15$  pF.
5.  $\pm 10\%$  duty cycle is supported for frequencies  $\leq 50$  MHz.
6. Maximum value only applies during Program/Erase Suspend/Resume commands.
7. When switching between die, a minimum time of  $t_{CS}$  must be kept between the rising edge of one chip select and the falling edge of the other for operations and data to be valid.

## 11.1 DDR AC Characteristics

**Table 11.2** DDR AC Characteristics 66 MHz Operation

| Symbol           | Parameter                                    | Min           | Typ | Max      | Unit |
|------------------|----------------------------------------------|---------------|-----|----------|------|
| $F_{SCK, R}$     | SCK Clock Frequency for DDR READ instruction | DC            |     | 66       | MHz  |
| $P_{SCK, R}$     | SCK Clock Period for DDR READ instruction    | 15            |     | $\infty$ | ns   |
| $t_{WH}, t_{CH}$ | Clock High Time                              | 45% $P_{SCK}$ |     |          | ns   |
| $t_{WL}, t_{CL}$ | Clock Low Time                               | 45% $P_{SCK}$ |     |          | ns   |
| $t_{CS}$         | CS# High Time (Read Instructions)            | 10            |     |          | ns   |
| $t_{CSS}$        | CS# Active Setup Time (relative to SCK)      | 3             |     |          | ns   |
| $t_{CSH}$        | CS# Active Hold Time (relative to SCK)       | 3             |     |          | ns   |
| $t_{SU}$         | IO in Setup Time                             | 2             |     | 3000 (2) | ns   |
| $t_{HD}$         | IO in Hold Time                              | 2             |     |          | ns   |
| $t_V$            | Clock Low to Output Valid                    | 0             |     | 6.5 (1)  | ns   |
| $t_{HO}$         | Output Hold Time                             | 0             |     |          | ns   |
| $t_{DIS}$        | Output Disable Time                          |               |     | 8        | ns   |
| $t_{LZ}$         | Clock to Output Low Impedance                | 0             |     | 8        | ns   |
| $t_{IO\_skew}$   | First IO to last IO data valid time          |               |     | 600      | ps   |

**Notes:**

1. Regulated  $V_{CC}$  range (3.0 - 3.6V) and  $CL = 15$  pF.
2. Maximum value only applies during Program/Erase Suspend/Resume commands.

## 11.2 Capacitance Characteristics

**Table 11.3** Capacitance

|           | Parameter                                              | Test Conditions | Min | Max | Unit |
|-----------|--------------------------------------------------------|-----------------|-----|-----|------|
| $C_{IN}$  | Input Capacitance (applies to SCK, CS#1, CS#2, RESET#) | 1 MHz           |     | 16  | pF   |
| $C_{OUT}$ | Output Capacitance (applies to All I/O)                | 1 MHz           |     | 16  | pF   |

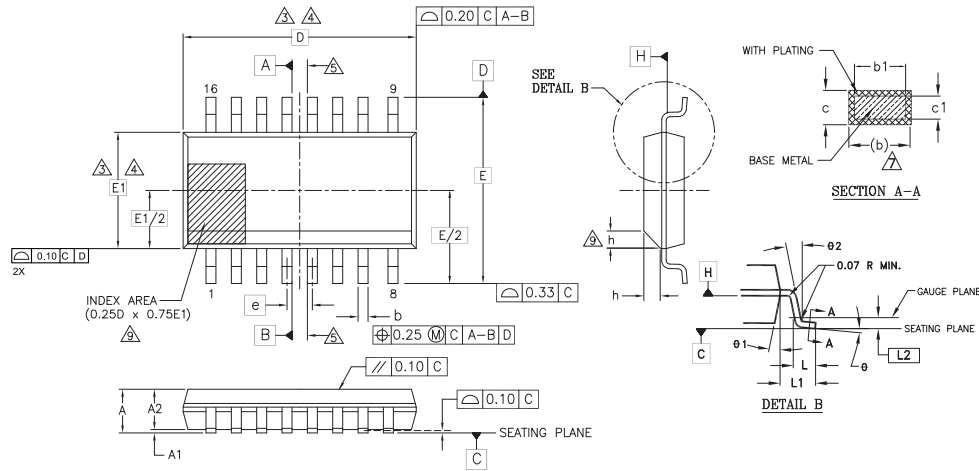
**Note:**

1. For more information on capacitance, please consult the IBIS models.



## 12. SOIC 16 Physical Diagram

### 12.1 SL3016 — 16-pin Wide Plastic Small Outline Package (300-mil Body Width)



| PACKAGE | SL3016 (inches) |       | SL3016 (mm) |      |
|---------|-----------------|-------|-------------|------|
| JEDEC   | MS-013(E)AA     |       | MS-013(E)AA |      |
| SYMBOL  | MIN             | MAX   | MIN         | MAX  |
| A       | 0.093           | 0.104 | 2.35        | 2.65 |
| A1      | 0.004           | 0.012 | 0.10        | 0.30 |
| A2      | 0.081           | 0.104 | 2.05        | 2.55 |
| b       | 0.012           | 0.020 | 0.31        | 0.51 |
| b1      | 0.011           | 0.019 | 0.27        | 0.48 |
| c       | 0.008           | 0.013 | 0.20        | 0.33 |
| c1      | 0.008           | 0.012 | 0.20        | 0.30 |
| D       | 0.406 BSC       |       | 10.30 BSC   |      |
| E       | 0.406 BSC       |       | 10.30 BSC   |      |
| E1      | 0.295 BSC       |       | 7.50 BSC    |      |
| e       | .050 BSC        |       | 1.27 BSC    |      |
| L       | 0.016           | 0.050 | 0.40        | 1.27 |
| L1      | .055 REF        |       | 1.40 REF    |      |
| L2      | .010 BSC        |       | 0.25 BSC    |      |
| N       | 16              |       | 16          |      |
| h       | 0.10            | 0.30  | 0.25        | 0.75 |
| θ       | 0°              | 8°    | 0°          | 8°   |
| θ1      | 5°              | 15°   | 5°          | 15°  |
| θ2      | 0°              | ---   | 0°          | ---  |

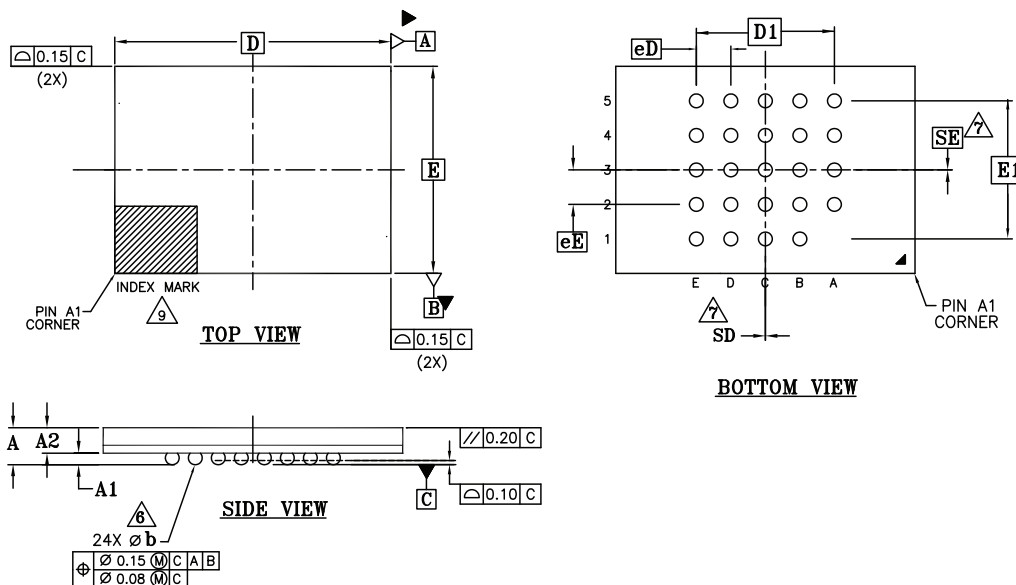
#### NOTES:

- ALL DIMENSIONS ARE IN BOTH INCHES AND MILLIMETERS.
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M - 1994.
- DIMENSION D DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 mm PER END. DIMENSION E1 DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 mm PER SIDE. D AND E1 DIMENSIONS ARE DETERMINED AT DATUM H.
- THE PACKAGE TOP MAY BE SMALLER THAN THE PACKAGE BOTTOM. DIMENSIONS D AND E1 ARE DETERMINED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY EXCLUSIVE OF MOLD FLASH, TIE BAR BURRS, GATE BURRS AND INTERLEAD FLASH, BUT INCLUDING ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.
- DATUMS A AND B TO BE DETERMINED AT DATUM H.
- "N" IS THE MAXIMUM NUMBER OF TERMINAL POSITIONS FOR THE SPECIFIED PACKAGE LENGTH.
- THE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.10 TO 0.25 mm FROM THE LEAD TIP.
- DIMENSION "b" DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.10 mm TOTAL IN EXCESS OF THE "b" DIMENSION AT MAXIMUM MATERIAL CONDITION. THE DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OF THE LEAD FOOT.
- THIS CHAMFER FEATURE IS OPTIONAL. IF IT IS NOT PRESENT, THEN A PIN 1 IDENTIFIER MUST BE LOCATED WITHIN THE INDEX AREA INDICATED.
- LEAD COPLANARITY SHALL BE WITHIN 0.10 mm AS MEASURED FROM THE SEATING PLANE.

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## 13. FAB024 Physical Diagram

### 13.1 FAB024 — 24-Ball BGA (8 x 6 mm) Package



| PACKAGE | FAB024                    |      |      |                             |
|---------|---------------------------|------|------|-----------------------------|
| JEDEC   | N/A                       |      |      |                             |
|         | 8.00mmx6.00mm NOM PACKAGE |      |      |                             |
| SYMBOL  | MIN.                      | NOM. | MAX. | NOTE                        |
| A       | —                         | —    | 1.20 | OVERALL THICKNESS           |
| A1      | 0.20                      | —    | —    | BALL HEIGHT                 |
| A2      | 0.70                      | —    | 0.90 | BODY THICKNESS              |
| D       | 8.00 BSC.                 |      |      | BODY SIZE                   |
| E       | 6.00 BSC.                 |      |      | BODY SIZE                   |
| D1      | 4.00 BSC.                 |      |      | BALL FOOTPRINT              |
| E1      | 4.00 BSC.                 |      |      | BALL FOOTPRINT              |
| MD      | 5                         |      |      | ROW MATRIX SIZE D DIRECTION |
| ME      | 5                         |      |      | ROW MATRIX SIZE E DIRECTION |
| N       | 24                        |      |      | TOTAL BALL COUNT            |
| φb      | 0.35                      | 0.40 | 0.45 | BALL DIAMETER               |
| e       | 1.00 BSC.                 |      |      | BALL PITCH                  |
| SD/SE   | 0.00                      |      |      | SOLDER BALL PLACEMENT       |
|         | A1                        |      |      | DEPOPULATED SOLDER BALLS    |
|         | I                         |      |      | PACKAGE OUTLINE TYPE        |

#### NOTES:

- DIMENSIONING AND TOLERANCING METHODS PER ASME Y14.5M-1994.
- ALL DIMENSIONS ARE IN MILLIMETERS.
- BALL POSITION DESIGNATION PER JEP95, SECTION 4.3, SPP-010.
- [e] REPRESENTS THE SOLDER BALL GRID PITCH.
- SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION. SYMBOL "ME" IS THE BALL MATRIX SIZE IN THE "E" DIRECTION. n IS THE NUMBER OF POPULATED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.
- DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL DIAMETER IN A PLANE PARALLEL TO DATUM C.
- SD AND SE ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW.
- WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW SD OR SE = 0.000.
- WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW, SD OR SE =  $\frac{e}{2}$
- "+" INDICATES THE THEORETICAL CENTER OF DEPOPULATED BALLS.
- A1 CORNER TO BE IDENTIFIED BY CHAMFER, LASER OR INK MARK, METALLIZED MARK INDENTATION OR OTHER MEANS.

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## 14. Revision History

| Section                               | Description                                                                                   |
|---------------------------------------|-----------------------------------------------------------------------------------------------|
| <b>Revision 01 (November 6, 2012)</b> |                                                                                               |
|                                       | Initial release                                                                               |
| <b>Revision 02 (April 25, 2013)</b>   |                                                                                               |
| Global                                | Data sheet designation updated from Advance Information to Preliminary                        |
| DC Characteristics                    | DC Characteristics table: changed Max value of $I_{LI}$ , $I_{LO}$ , $I_{CC1}$ , and $I_{SB}$ |
| <b>Revision 03 (May 16, 2013)</b>     |                                                                                               |
| SOIC 16 Physical Diagram              | Updated package nomenclature from S03016 to SL3016                                            |
| <b>Revision 04 (August 22, 2013)</b>  |                                                                                               |
| Valid Combinations                    | Valid Combinations table: added MFV                                                           |
| DC Characteristics                    | DC Characteristics table: added $I_{SB}$ (Automotive)                                         |
| <b>Revision 05 (November 8, 2013)</b> |                                                                                               |
| Global                                | Data sheet designation updated from Preliminary to Full Production                            |
| <b>Revision 06 (March 19, 2014)</b>   |                                                                                               |
| Features                              | Packages (all Pb-free): added BGA-24, 8 x 6 mm                                                |
| Connections Diagrams                  | Added figure: 24-Ball BGA, 5 x 5 Ball Footprint (FAB024), Top View                            |
| Ordering Information                  | Added options to: Model Number, Package Materials, Package Type, and Speed                    |
| Valid Combinations                    | Added option to S70FL01GS Valid Combinations Table                                            |
| SDR AC Characteristics                | SDR AC Characteristics (Single Die Package, VCC = 2.7V to 3.6V) table: updated $t_v$ Min      |
| DDR AC Characteristics                | Updated DDR AC Characteristics 66 MHz Operation table                                         |
| Capacitance Characteristics           | Capacitance table: updated Max values and removed note                                        |

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